19-0270; Rev 2; 4/04

MAXIM

Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

General Description

The MAX306/MAX307 precision, monolithic, CMOS analog multiplexers (muxes) offer low on-resistance (less than 100Ω), which is matched to within 5Ω between channels and remains flat over the specified analog signal range (7Ω, max). They also offer low leakage over temperature ($I_{NO(OFF)}$ less than 2.5nA at +85°C) and fast switching speeds (t_{TRANS} less than 250ns). The MAX306 is a single-ended 1-of-16 device, and the MAX307 is a differential 2-of-8 device.

The MAX306/MAX307 are fabricated with Maxim's improved 44V silicon-gate process. Design improvements yield extremely low charge injection (less than 10pC) and guarantee electrostatic discharge (ESD) protection greater than 2000V.

These muxes operate with a single +4.5V to +30V supply, or bipolar ±4.5V to ±20V supplies, while retaining TTL/CMOS-logic input compatibility and fast switching. CMOS inputs provide reduced input loading. These improved parts are plug-in upgrades for the industry-standard DG406, DG407, DG506A, and DG507A.

Applications

- Sample-and-Hold Circuits
- Test Equipment
- Heads-Up Displays
- Guidance and Control Systems
- Military Radios
- Communications Systems
- Battery-Operated Systems
- PBX, PABX
- Audio Signal Routing

Features

- ♦ **Guaranteed On-Resistance Match Between Channels, <5Ω Max**
- ♦ **Low On-Resistance, <100Ω Max**
- ♦ **Guaranteed Flat On-Resistance over Specified Signal Range, 7Ω Max**
- ♦ **Guaranteed Charge Injection, <10pC**
- ♦ **$I_{NO(OFF)}$ Leakage <2.5nA at +85°C**
- ♦ **$I_{COM(OFF)}$ Leakage <20nA at +85°C**
- ♦ **ESD Protection >2000V**
- ♦ **Plug-In Upgrade for Industry-Standard DG406/DG407/DG506A/DG507A**
- ♦ **Single-Supply Operation (+4.5V to +30V) Bipolar-Supply Operation (±4.5V to ±20V)**
- ♦ **Low Power Consumption, <1.25mW**
- ♦ **Rail-to-Rail Signal Handling**
- ♦ **TTL/CMOS-Logic Compatible**

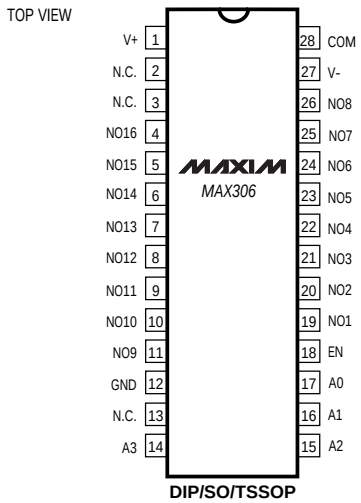
Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX306CPI	0°C to +70°C	28 Plastic DIP
MAX306CWI	0°C to +70°C	28 Wide SO
MAX306C/D	0°C to +70°C	Dice*
MAX306EPI	-40°C to +85°C	28 Plastic DIP
MAX306EWI	-40°C to +85°C	28 Wide SO
MAX306EQI	-40°C to +85°C	28 PLCC
MAX306EUI	-40°C to +85°C	28 TSSOP
MAX306MJI	-55°C to +125°C	28 CERDIP

Ordering Information continued at end of data sheet.

**Contact factory for dice specifications.*

Pin Configurations/Functional Diagrams/Truth Tables



DIP/SO/TSSOP

A3	A2	A1	A0	EN	ON Switch
X	X	X	X	0	None
0	0	0	0	1	1
0	0	0	1	1	2
0	0	1	0	1	3
0	0	1	1	1	4
0	1	0	0	1	5
0	1	0	1	1	6
0	1	1	0	1	7
0	1	1	1	1	8
1	0	0	0	1	9
1	0	0	1	1	10
1	0	1	0	1	11
1	0	1	1	1	12
1	1	0	0	1	13
1	1	0	1	1	14
1	1	1	0	1	15
1	1	1	1	1	16

MAX306
LOGIC "0" $V_{AL} \le 0.8V$, LOGIC "1" = $V_{AH} \ge 2.4V$

Pin Configurations/Functional Diagrams/Truth Tables continued at end of data sheet.

Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

ABSOLUTE MAXIMUM RATINGS

(Voltage Referenced to V-)
V+ .....-0.3V, +44V
GND.....-0.3V, +25V
Digital Inputs, NO, COM (Note 1).....(V- - 2V) to (V+ + 2V) or 30mA (whichever occurs first)
Continuous Current (any terminal).....30mA
Peak Current, NO or COM
(pulsed at 1ms, 10% duty cycle max) 100mA
Continuous Power Dissipation (T_A = +70°C)
28-Pin Plastic DIP
(derate 9.09mW/°C above +70°C).....727mW
28-Pin Wide SO (derate 12.50mW/°C above +70°C) ...1000mW
28-Pin PLCC (derate 10.53mW/°C above +70°C).....842mW
28-Pin CERDIP (derate 16.67mW/°C above +70°C) ..1333mW
28-Pin TSSOP (derate 12.8mW/°C above +70°C).....1025mW
Operating Temperature Ranges
MAX30_C_ _ .....0°C to +70°C
MAX30_E_ _.....-40°C to +85°C
MAX30_MJI.....-55°C to +125°C
Storage Temperature Range.....-65°C to +150°C
Lead Temperature (soldering, 10s) .....+300°C

Note 1: Signals on NO, COM, A0, A1, A2, A3, or EN exceeding V+ or V- are clamped by internal diodes. Limit forward current to maximum current ratings.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS—Dual Supplies

(V+ = +15V, V- = -15V, GND = 0V, V_{AH} = +2.4V, V_{AL} = +0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS				MIN	TYP (Note 2)	MAX	UNITS
SWITCH									
Analog Signal Range	V_{NO}, V_{COM}	(Note 3)				-15		+15	V
On-Resistance	R_{ON}	I_{NO} = -1.0mA, V_{COM} = ±10V		T_A = +25°C			60	100	Ω
				T_A = T_{MIN} to T_{MAX}				125	
On-Resistance Matching Between Channels	ΔR_{ON}	I_{NO} = -1.0mA, V_{COM} = ±10V (Note 4)		T_A = +25°C			1.5	5	Ω
				T_A = T_{MIN} to T_{MAX}				8	
On-Resistance Flatness	R_{FLAT}	I_{NO} = -1.0mA, V_{COM} = ±5V or 0V		T_A = +25°C			1.8	7	Ω
				T_A = T_{MIN} to T_{MAX}				10	
NO Off-Leakage Current (Note 5)	$I_{NO(OFF)}$	V_{COM} = ∓10V, V_{NO} = ±10V, V_{EN} = 0V		T_A = +25°C		-0.5	+0.01	+0.5	nA
				T_A = T_{MIN} to T_{MAX}	C, E	-2.5		+2.5	
					M	-5.0		+5.0	
COM Off-Leakage Current (Note 5)	$I_{COM(OFF)}$	V_{NO} = ±10V, V_{COM} = ∓10V, V_{EN} = 0V	MAX306	T_A = +25°C		-0.75	+0.02	+0.75	nA
				T_A = T_{MIN} to T_{MAX}	C, E	-20		+20	
					M	-40		+40	
		V_{NO} = ∓10V, V_{COM} = ±10V, V_{EN} = 0V	MAX307	T_A = +25°C		-0.75	+0.02	+0.75	
				T_A = T_{MIN} to T_{MAX}	C, E	-10		+10	
					M	-20		+20	
COM On-Leakage Current (Note 5)	$I_{COM(ON)}$	V_{COM} = ±10V, V_{NO} = ±10V, sequence each switch on	MAX306	T_A = +25°C		-0.75	+0.02	+0.75	nA
				T_A = T_{MIN} to T_{MAX}	C, E	-25		+25	
					M	-50		+50	
			MAX307	T_A = +25°C		-0.75	+0.02	+0.75	
				T_A = T_{MIN} to T_{MAX}	C, E	-12.5		+12.5	
					M	-25		+25	

ELECTRICAL CHARACTERISTICS—Dual Supplies (continued)

(V+ = +15V, V- = -15V, GND = 0V, V_{AH} = +2.4V, V_{AL} = +0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS			MIN	TYP (Note 2)	MAX	UNITS
INPUT								
Input Current with Input Voltage High	I_{AH}	V_A = 2.4V or 15V			-1.0		+1.0	µA
Input Current with Input Voltage Low	I_{AL}	V_{EN} = 0V or 2.4V, V_A = 0V			-1.0		+1.0	µA
SUPPLY								
Power-Supply Range					±4.5		±20	V
Positive Supply Current	I+	V_{EN} = V_A = 0V or 5.0V		T_A = +25°C		16	30	µA
				T_A = T_{MIN} to T_{MAX}			75	
		V_{EN} = 2.4V, $V_{A(ALL)}$ = 0V		T_A = +25°C		0.075	0.5	mA
				T_A = T_{MIN} to T_{MAX}			1	
Negative Supply Current	I-	V_{EN} = 2.4V, $V_{A(ALL)}$ = 0V		T_A = +25°C	-1		+1	µA
				T_A = T_{MIN} to T_{MAX}	-10		+10	
DYNAMIC								
Transition Time	t_{TRANS}	Figure 2		T_A = +25°C		110	300	ns
				T_A = T_{MIN} to T_{MAX}			400	
Break-Before-Make Interval	t_{OPEN}	Figure 4		T_A = +25°C	10	40		ns
Enable Turn-On Time	$t_{ON(EN)}$	Figure 3		T_A = +25°C		130	200	ns
				T_A = T_{MIN} to T_{MAX}			400	
Enable Turn-Off Time	$t_{OFF(EN)}$	Figure 3		T_A = +25°C		55	150	ns
				T_A = T_{MIN} to T_{MAX}			300	
Charge Injection (Note 3)	Q	C_L = 1.0nF, V_{NO} = 0V, R_S = 0Ω, Figure 5		T_A = +25°C		2	10	pC
Off-Isolation (Note 6)	V_{ISO}	V_{EN} = 0V, R_L = 1kΩ, f = 100kHz, Figure 6		T_A = +25°C		-69		dB
Crosstalk Between Channels	V_{CT}	V_{EN} = 2.4V, f = 100kHz, V_{GEN} = $1V_{P-P}$, R_L = 1kΩ, Figure 7		T_A = +25°C		-92		dB
Logic Input Capacitance	C_{IN}	f = 1MHz		T_A = +25°C		8		pF
NO Off-Capacitance	$C_{NO(OFF)}$	f = 1MHz, V_{EN} = V_{NO} = 0V, Figure 8		T_A = +25°C		8		pF
COM Off-Capacitance	$C_{COM(OFF)}$	f = 1MHz, V_{EN} = 0.8V, V_{COM} = 0V, Figure 8	MAX306	T_A = +25°C		130		pF
			MAX307			65		
COM On-Capacitance	$C_{COM(ON)}$	f = 1MHz, V_{EN} = 2.4V, V_{COM} = 0V, Figure 8	MAX306	T_A = +25°C		140		pF
			MAX307			70		

ELECTRICAL CHARACTERISTICS—Single Supply

(V+ = +12V, V- = 0V, GND = 0V, V_{AH} = +2.4V, V_{AL} = +0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP (Note 2)	MAX	UNITS
SWITCH							
Analog Signal Range	V_{NO}, V_{COM}	(Note 3)		0		12	V
On-Resistance	R_{ON}	I_{NO} = -1.0mA V_{COM} = 3V or 10V	T_A = +25°C		120	175	Ω
DYNAMIC							
Transition Time (Note 3)	t_{TRANS}	V_{NO1} = 8V, V_{NO8} = 0V, V_{IN} = 2.4V, Figure 1	T_A = +25°C		130	450	ns
Enable Turn-On Time (Note 3)	$t_{ON(EN)}$	V_{INH} = 2.4V, V_{INL} = 0V, V_{NO1} = 5V, Figure 3	T_A = +25°C		105	600	ns
Enable Turn-Off Time (Note 3)	$t_{OFF(EN)}$	V_{INH} = 2.4V, V_{INL} = 0V, V_{NO1} = 5V, Figure 3	T_A = +25°C		80	300	ns
Charge Injection (Note 3)	Q	C_L = 1.0nF, V_{NO} = 0V, R_S = 0Ω	T_A = +25°C		2	10	pC

Note 2: The algebraic convention where the most negative value is a minimum and the most positive value a maximum is used in this data sheet.

Note 3: Guaranteed by design.

Note 4: $\Delta R_{ON} = R_{ON(MAX)} - R_{ON(MIN)}$. On-resistance match between channels and flatness are guaranteed only with specified voltages. Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured at the extremes of the specified analog signal range.

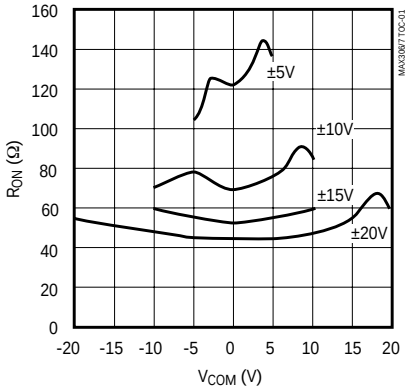
Note 5: Leakage parameters are 100% tested at the maximum-rated hot temperature and guaranteed by correlation at +25°C.

Note 6: Off-isolation = 20log V_{COM}/V_{NO}, where V_{COM} = output and V_{NO} = input to off switch.

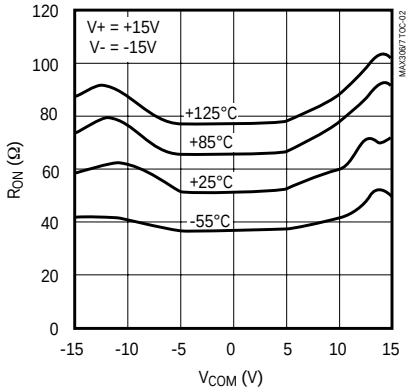
Typical Operating Characteristics

(T_A = +25°C, unless otherwise noted.)

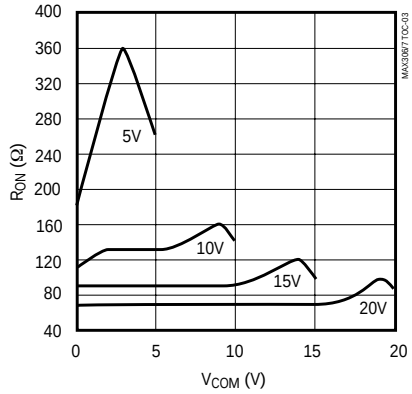
ON-RESISTANCE vs. V_{COM} (DUAL SUPPLIES)



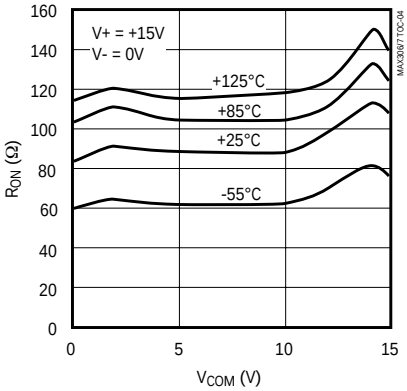
ON-RESISTANCE vs. V_{COM} AND TEMPERATURE (DUAL SUPPLIES)



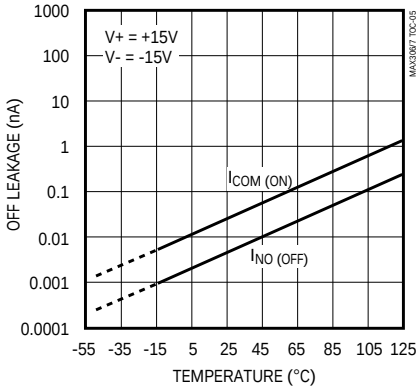
ON-RESISTANCE vs. V_{COM} (SINGLE SUPPLY)



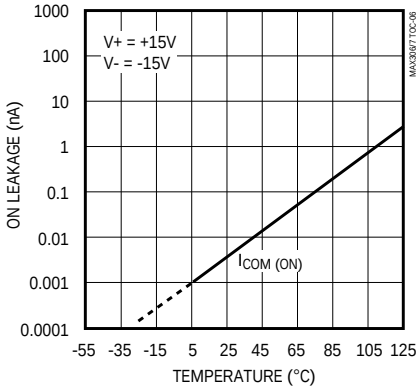
ON-RESISTANCE vs. V_{COM} AND TEMPERATURE (SINGLE SUPPLY)



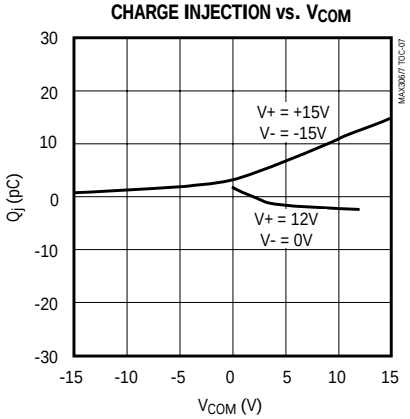
OFF LEAKAGE vs. TEMPERATURE



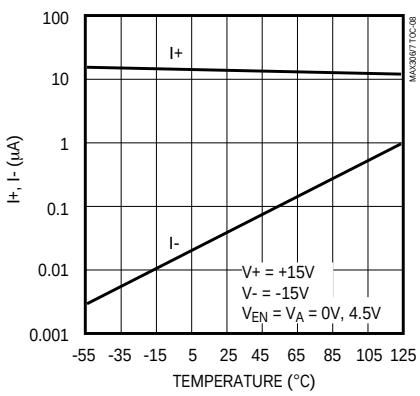
ON LEAKAGE vs. TEMPERATURE



CHARGE INJECTION vs. V_{COM}



SUPPLY CURRENT vs. TEMPERATURE



Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

Pin Descriptions

MAX306 PIN	NAME	FUNCTION
1	V+	Positive Supply Voltage Input
2, 3, 13	N.C.	No Connection. Not internally connected.
4–11	NO16–NO9	Analog Inputs–bidirectional
12	GND	Ground
14–17	A3–A0	Address Inputs
18	EN	Enable Inputs
19–26	NO1–NO8	Analog Inputs–bidirectional
27	V-	Negative Supply Voltage Input
28	COM	Output–bidirectional

MAX307 PIN	NAME	FUNCTION
1	V+	Positive Supply Voltage Input
2	COMB	Output B–bidirectional
3, 13, 14	N.C.	No Connection. Not internally connected.
4–11	NO8B–NO1B	Analog Inputs–bidirectional
12	GND	Ground
15, 16, 17	A2, A1, A0	Address Inputs
18	EN	Enable Input
19–26	NO1A–NO8A	Analog Inputs–bidirectional
27	V-	Negative Supply Voltage Input
28	COMA	Output A–bidirectional

Applications Information

Operation with Supply Voltages Other than ±15V

Using supply voltages other than ±15V will reduce the analog signal range. The MAX306/MAX307 switches operate with ±4.5V to ±20V bipolar supplies or with a +4.5V to +30V single supply; connect V- to GND when operating with a single supply. Also, both device types can operate with unbalanced supplies such as +24V and -5V. The *Typical Operating Characteristics* graphs show typical on-resistance with 20V, 15V, 10V, and 5V supplies. (Switching times increase by a factor of two or more for operation at 5V.)

Overvoltage Protection

Proper power-supply sequencing is recommended for all CMOS devices. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings may cause permanent damage to the devices. Always sequence V+ on first, then V-, followed by either the logic inputs, NO or COM. If power-supply sequencing is not possible, add two small-signal diodes in series with supply pins for overvoltage protection (Figure 1). Adding diodes reduces the analog signal range to 1V above V+ and 1V below V-, but low switch resistance and low leakage characteristics are unaffected. Device operation is unchanged, and the difference between V+ and V- should not exceed +44V.

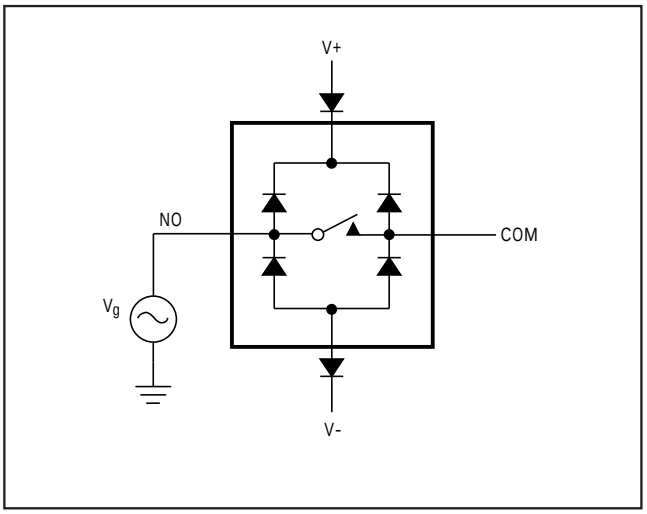


Figure 1. Overvoltage Protection Using External Blocking Diodes

Test Circuits/Timing Diagrams

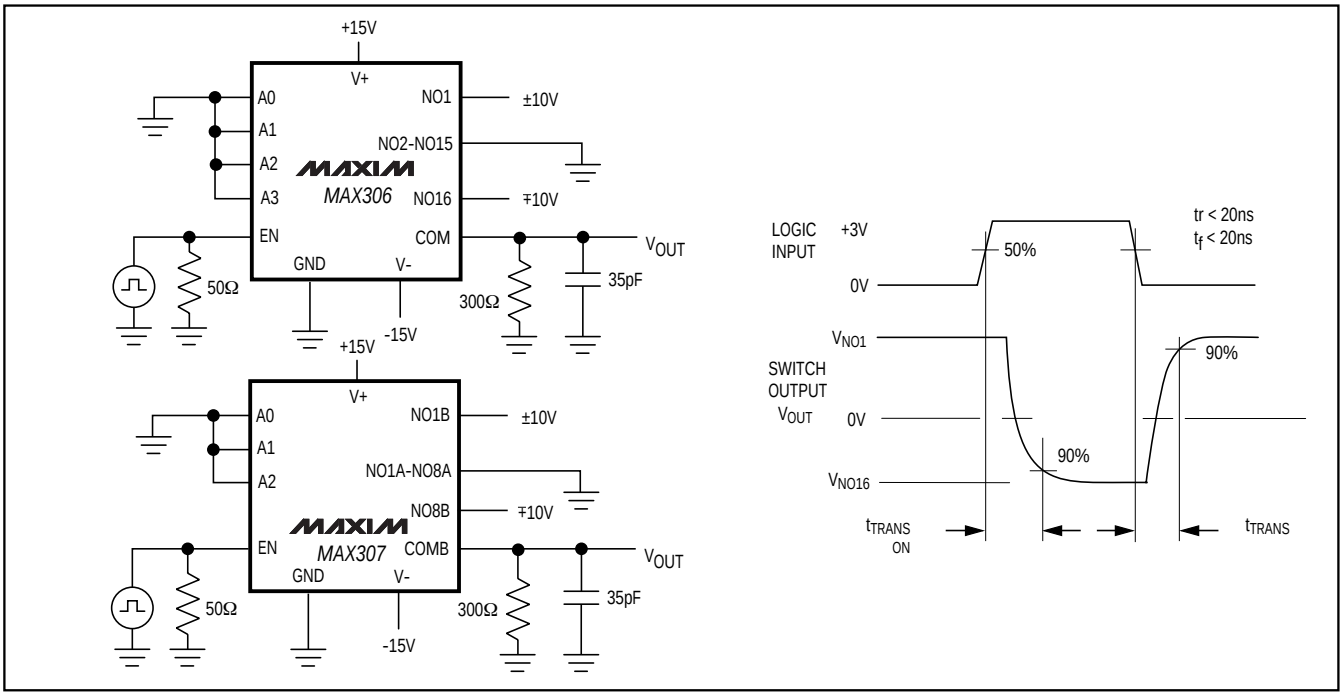


Figure 2. Transition Time

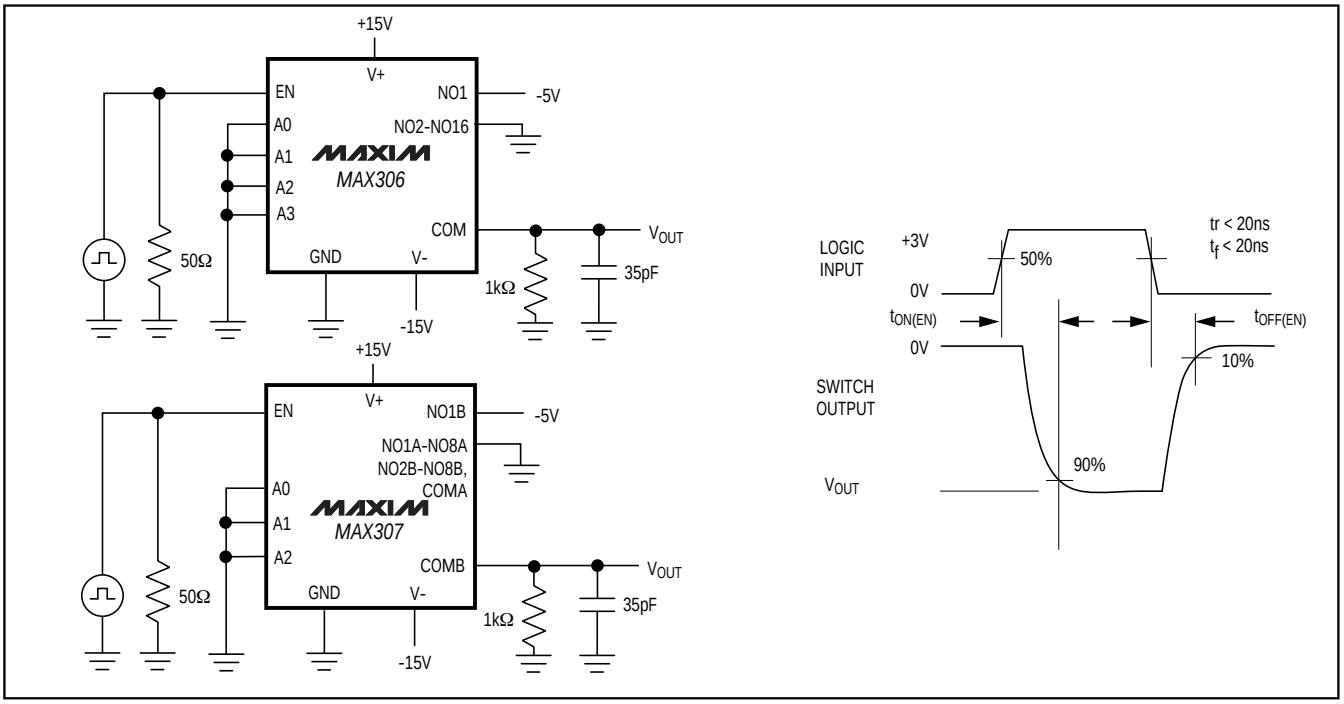


Figure 3. Enable Switching Time

Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

Test Circuits/Timing Diagrams (continued)

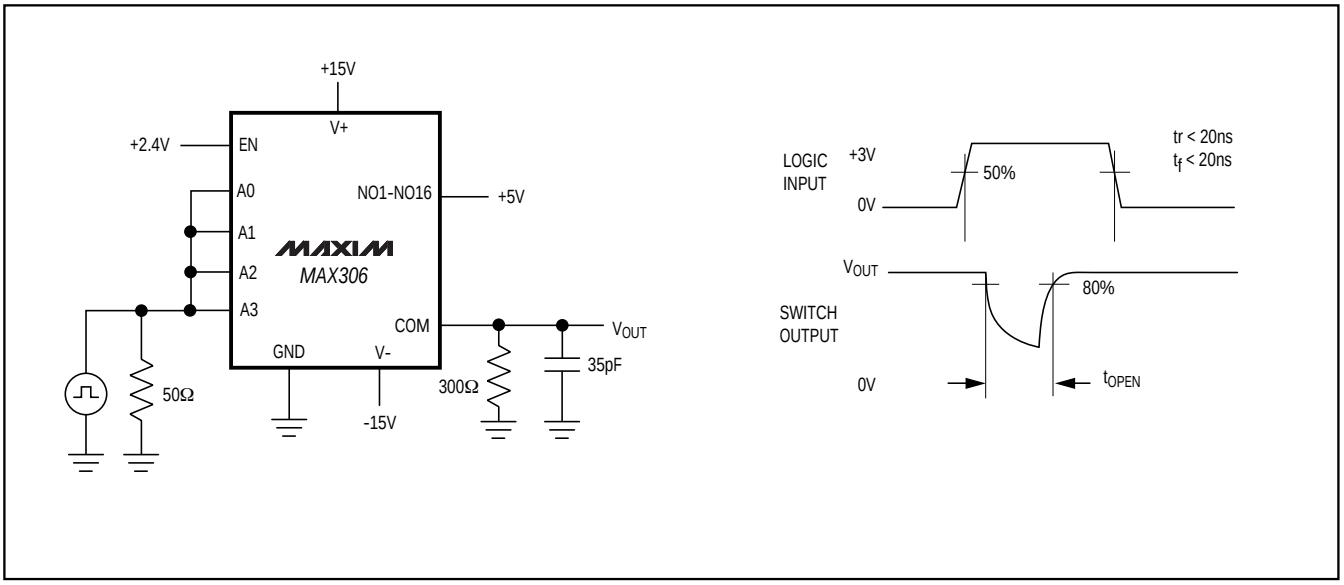


Figure 4. Break-Before-Make Interval

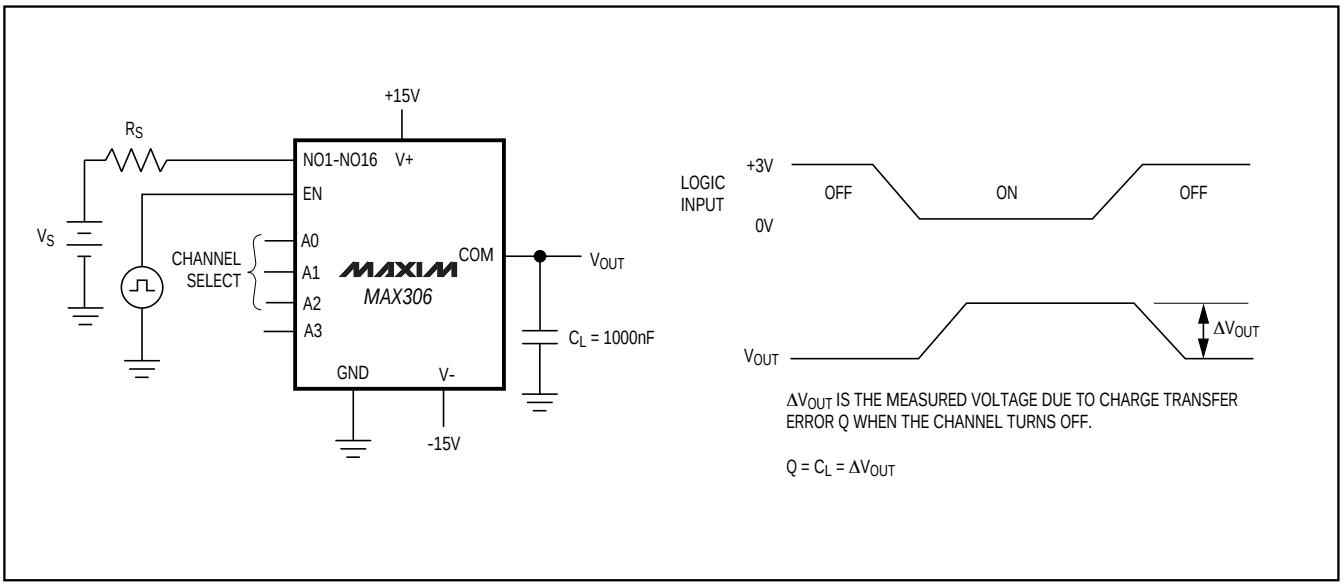


Figure 5. Charge Injection

Test Circuits/Timing Diagrams (continued)

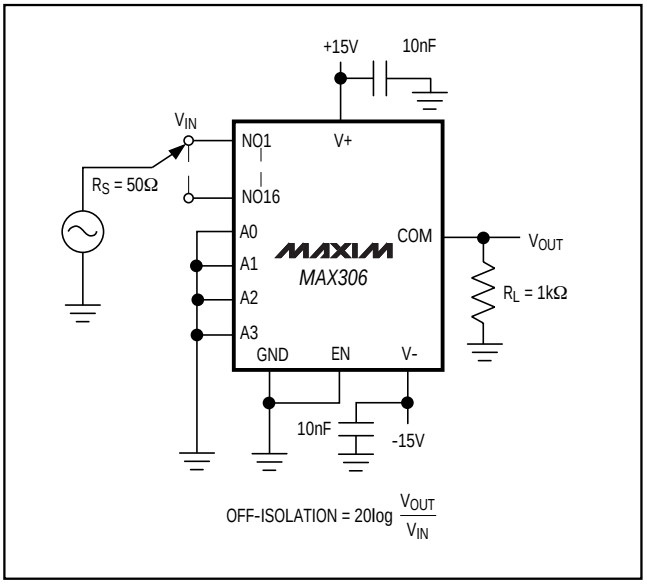


Figure 6. Off-Isolation

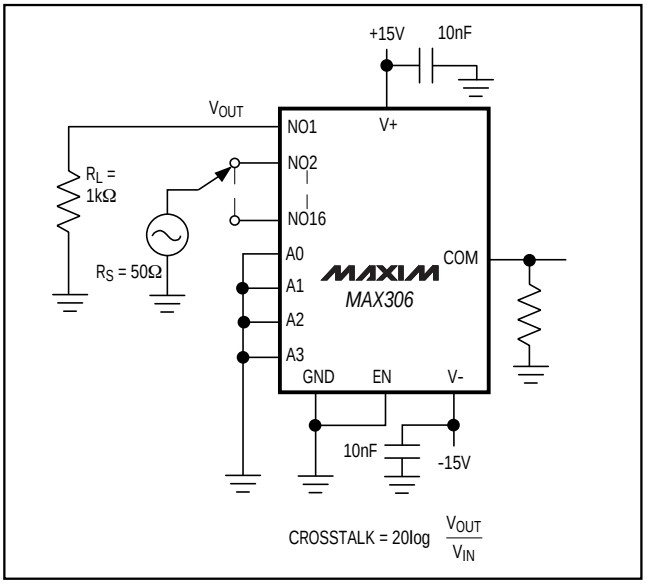


Figure 7. Crosstalk

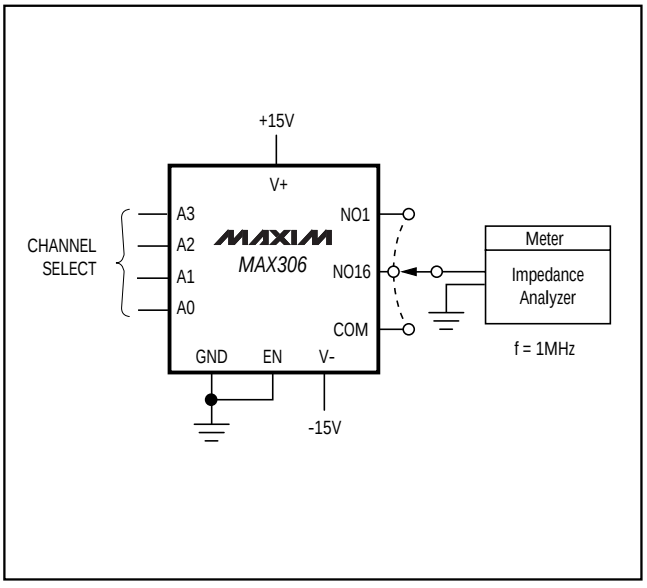
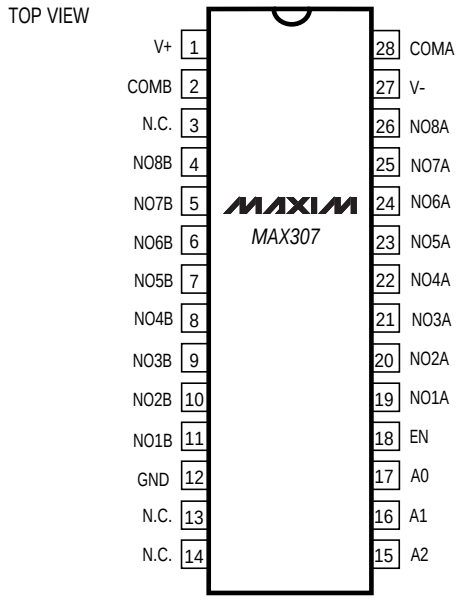


Figure 8. NO/COM Capacitance

Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

Pin Configurations/Functional Diagrams/Truth Tables (continued)

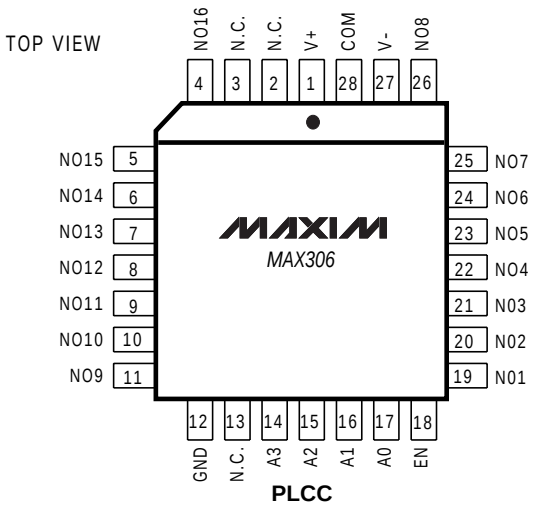


DIP/SO

A2	A1	A0	EN	ON Switch
X	X	X	0	None
0	0	0	1	1
0	0	1	1	2
0	1	0	1	3
0	1	1	1	4
1	0	0	1	5
1	0	1	1	6
1	1	0	1	7
1	1	1	1	8

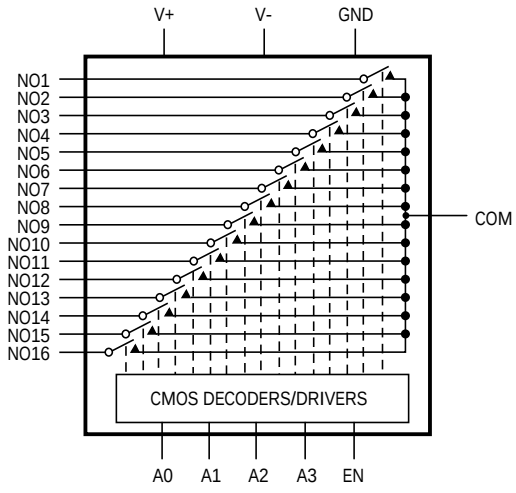
MAX307

LOGIC "0" $V_{AL} \leq 0.8V$, LOGIC "1" = $V_{AH} \geq 2.4V$



PLCC

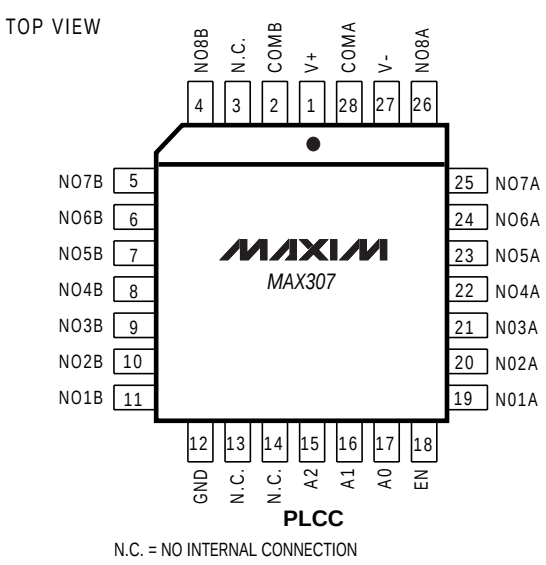
N.C. = NO INTERNAL CONNECTION



MAX306 16-CHANNEL SINGLE-ENDED MULTIPLEXER

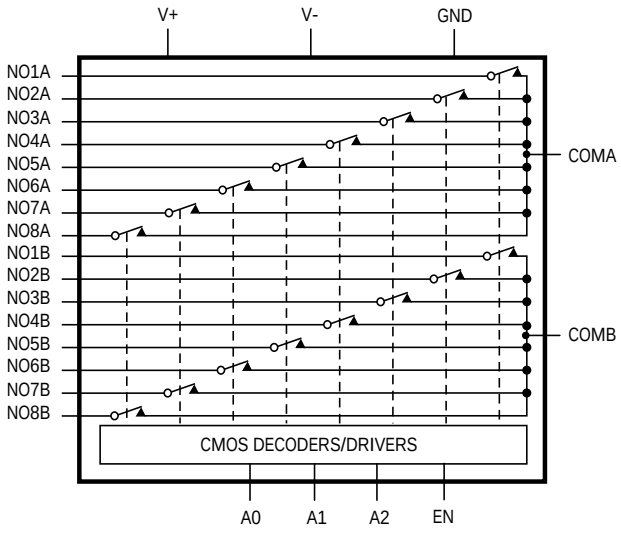
Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

_____Pin Configurations/Functional Diagrams/Truth Tables (continued)



PLCC

N.C. = NO INTERNAL CONNECTION



MAX307 8-CHANNEL DIFFERENTIAL MULTIPLEXER

_Ordering Information (continued)

PART	TEMP RANGE	PIN-PACKAGE
MAX307CPI	0°C to +70°C	28 Plastic DIP
MAX307CWI	0°C to +70°C	28 Wide SO
MAX307C/D	0°C to +70°C	Dice*
MAX307EPI	-40°C to +85°C	28 Plastic DIP
MAX307EWI	-40°C to +85°C	28 Wide SO
MAX307EQI	-40°C to +85°C	28 PLCC
MAX307EUI	-40°C to +85°C	28 TSSOP
MAX307MJI	-55°C to +125°C	28 CERDIP

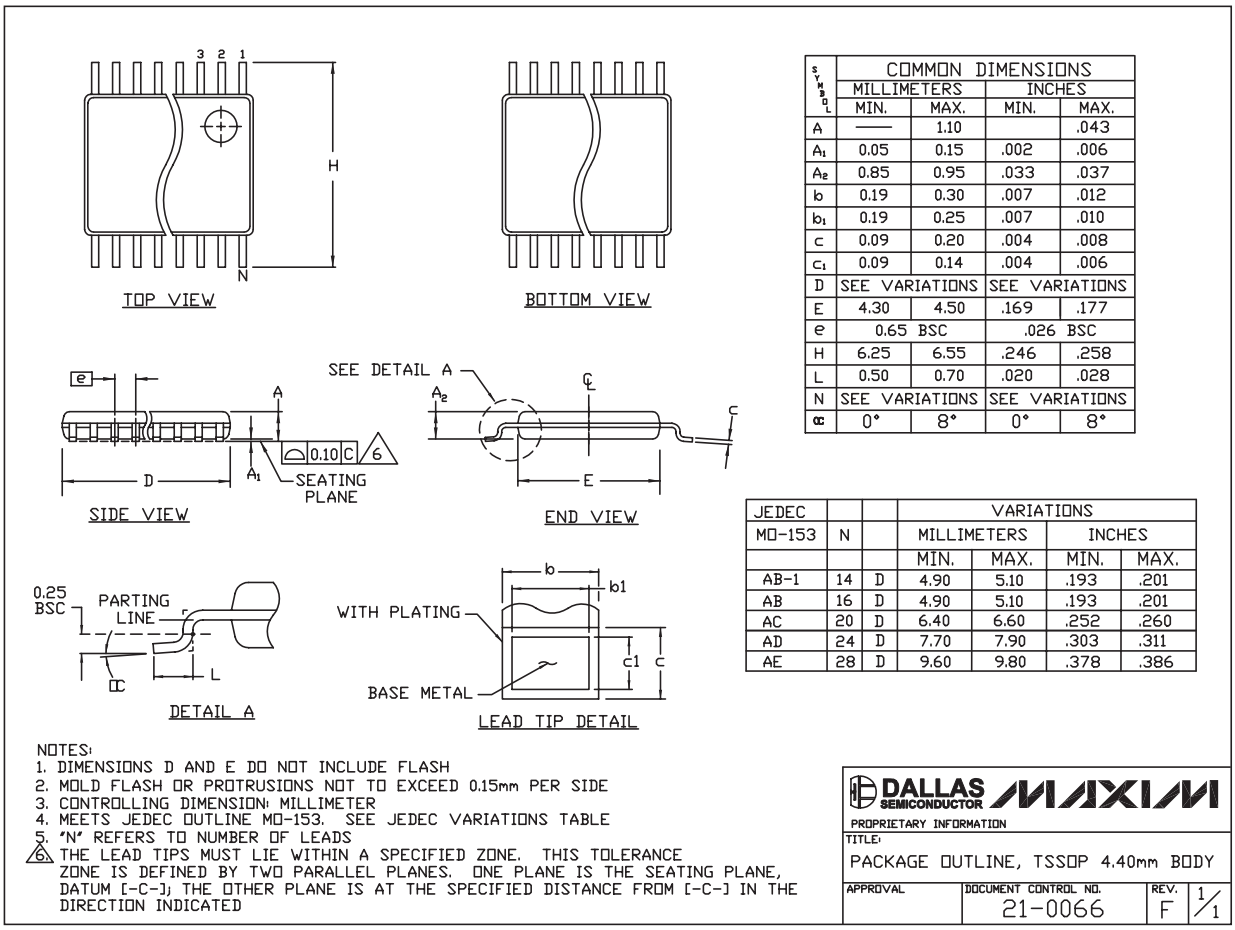
** Contact factory for dice specifications.*

Precision, 16-Channel/Dual 8-Channel, High-Performance, CMOS Analog Multiplexers

Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to **www.maxim-ic.com/packages**.)

TSSOP4.40mm.EPS



SYMBOL	COMMON DIMENSIONS			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	——	1.10		.043
A_1	0.05	0.15	.002	.006
A_2	0.85	0.95	.033	.037
b	0.19	0.30	.007	.012
b_1	0.19	0.25	.007	.010
c	0.09	0.20	.004	.008
c_1	0.09	0.14	.004	.006
D	SEE VARIATIONS		SEE VARIATIONS	
E	4.30	4.50	.169	.177
e	0.65 BSC		.026 BSC	
H	6.25	6.55	.246	.258
L	0.50	0.70	.020	.028
N	SEE VARIATIONS		SEE VARIATIONS	
α	0°	8°	0°	8°

JEDEC			VARIATIONS			
MO-153	N		MILLIMETERS		INCHES	
			MIN.	MAX.	MIN.	MAX.
AB-1	14	D	4.90	5.10	.193	.201
AB	16	D	4.90	5.10	.193	.201
AC	20	D	6.40	6.60	.252	.260
AD	24	D	7.70	7.90	.303	.311
AE	28	D	9.60	9.80	.378	.386

NOTES:
1. DIMENSIONS D AND E DO NOT INCLUDE FLASH
2. MOLD FLASH OR PROTRUSIONS NOT TO EXCEED 0.15mm PER SIDE
3. CONTROLLING DIMENSION: MILLIMETER
4. MEETS JEDEC OUTLINE MO-153. SEE JEDEC VARIATIONS TABLE
5. "N" REFERS TO NUMBER OF LEADS
6. THE LEAD TIPS MUST LIE WITHIN A SPECIFIED ZONE. THIS TOLERANCE ZONE IS DEFINED BY TWO PARALLEL PLANES. ONE PLANE IS THE SEATING PLANE, DATUM [-C-], THE OTHER PLANE IS AT THE SPECIFIED DISTANCE FROM [-C-] IN THE DIRECTION INDICATED

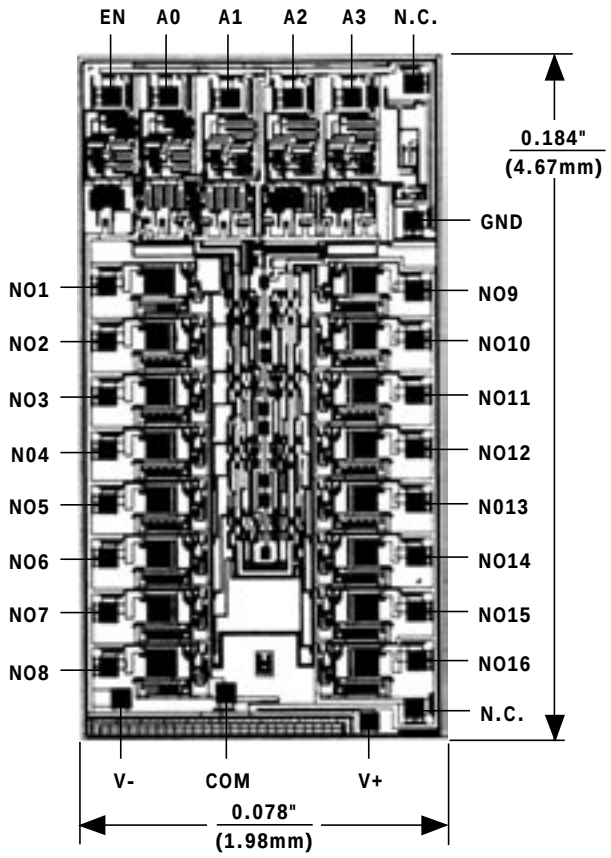
DALLAS SEMICONDUCTOR MAXIM
PROPRIETARY INFORMATION

TITLE: PACKAGE OUTLINE, TSSOP 4.40mm BODY

APPROVAL	DOCUMENT CONTROL NO.	REV.	
	21-0066	F	1/1

Chip Topographies

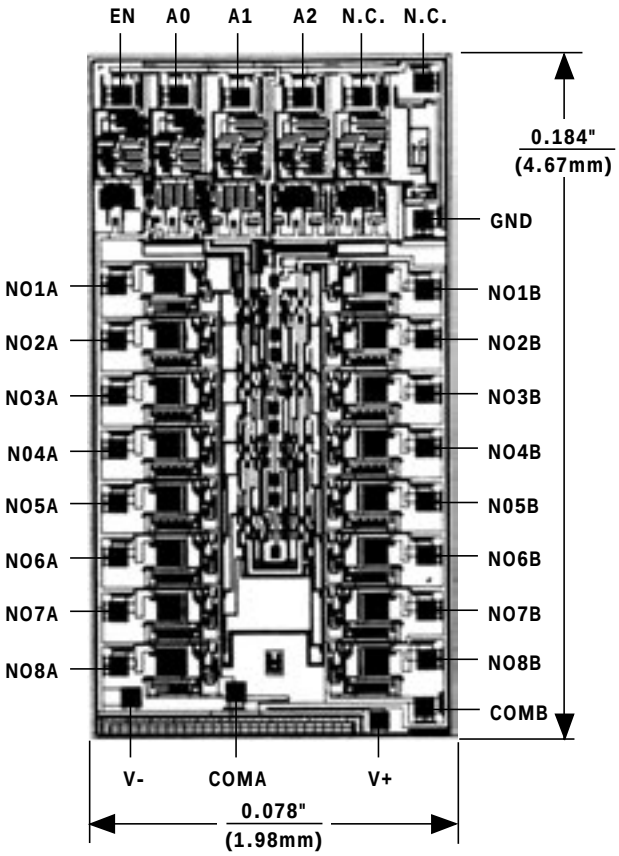
MAX306



TRANSISTOR COUNT: 269

SUBSTRATE IS INTERNALLY CONNECTED TO V+

MAX307



TRANSISTOR COUNT: 269

SUBSTRATE IS INTERNALLY CONNECTED TO V+

N.C. = NO INTERNAL CONNECTION